

Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/708,825	BEENAU ET AL.	
Examiner	Art Unit	_
Daniel I. Walsh	2876	

SEARCHED						
Class	Subclass	Date	Examiner			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST Search attached	12/1/2005	DW		
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